

Notice of References Cited

Application/Control No.

10/530,701

Applicant(s)/Patent Under
Reexamination
EDVARDSEN ET AL.

Examiner

Andrew C. Lee

Art Unit

2619

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-2002/0075844 | 06-2002 | Hagen, W. Alexander | 370/351 |
| * | B | US-6,925,074 | 08-2005 | Vikberg et al. | 370/338 |
| * | C | US-7,289,478 | 10-2007 | Kim et al. | 370/338 |
| * | D | US-6,778,517 | 08-2004 | Lou et al. | 370/338 |
| * | E | US-2004/0141522 | 07-2004 | Texerman et al. | 370/466 |
| * | F | US-2003/0139180 | 07-2003 | McIntosh et al. | 455/426 |
| * | G | US-7,307,963 | 12-2007 | Chow et al. | 370/259 |
| * | H | US-7,002,995 | 02-2006 | Chow et al. | 370/485 |
| * | I | US-7,230,915 | 06-2007 | Kobayashi, Naofumi | 370/226 |
| * | J | US-2003/0048799 | 03-2003 | Jang, Kyung-Hun | 370/431 |
| * | K | US-6,973,057 | 12-2005 | Forslow, Jan E. | 370/328 |
| * | L | US-6,829,486 | 12-2004 | McKenna et al. | 455/464 |
| * | M | US-7,136,361 | 11-2006 | Benveniste, Mathilde | 370/310.2 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | |
|---|---|---|--|--|--|--|
| | U | | | | | |
| | V | | | | | |
| | W | | | | | |
| | X | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.